Search Notes

Application/Control	No. Applicant(s)/Patent und Reexamination	er
09/527,931	MATHIEU ET AL.	
Examiner	Art Unit	
Rick K. Chang	3729	

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	SEARCHED				
Class	Subclass	Date	Examiner		
search	updated	2/8/2006	RC		
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INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		 	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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